TOSHIBA Bipolar Linear Integrated Circuit Silicon Monolithic

TA7522S,TA7522F

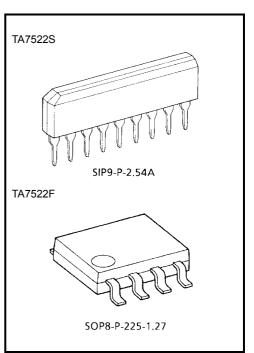
Dual Voltage Comparator

The TA7522S, TA7522F is an easy-to-use IC incorporating two voltage comparator circuits.

Since one channel has an inverted-output buffer, a CR oscillator can be easily built up. In addition, the IC has so wide an operating temperature range that it can be used in wide application fields.

Features

- Two-circuit package
- High gain
- Single 3V power supply for operation
- Inverted-output also available
- A 0V input causes action in the IC with a single power supply.
- Wide common-mode input range
- No latch-up
- Operating temperature range : from -40 to 85°C
- Open-collector output
- SIP-9 pin (TA7522S)
- SOP-8 pin (TA7522F)

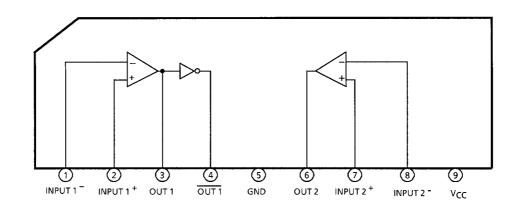


Weight

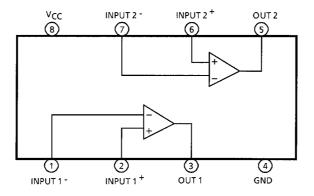
SIP9-P-2.54A : 0.92 g (typ.) SOP8-P-225-1.27 : 0.08 g (typ.)

Block Diagram And Pin Layout

TA7522S



TA7522F



Note : The TA7522S and TA7522F are the same chip, except that they are housed in different packages.

Pin Description

Pin No.				
TA7522S	TA7522F	Symbol	Description	
1	1	INPUT1 ⁻	Inverted-input pin	
2	2	INPUT1 ⁺	Non-inverted-input pin	
3	3	OUT1	Output pin corresponding to INPUT1	
4	_	OUT1	Output pin for inversion of OUT1	
5	4	GND	Grounded	
6	5	OUT2	Output pin corresponding to INPUT2	
7	6	INPUT2 ⁺	Non-inverted-input pin	
8	7	INPUT2 ⁻	Inverted-input pin	
9	8	V _{CC}	Power supply pin	

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Supply Voltage	V _{CC}	-0.3 to +18	V
Supply Voltage Surge	V _{CC SURGE}	+30 (within 1 second)	V
Power Dissipation	PD	500 / 440	mW
Differential Input Voltage	DV _{IN}	±18	V
Input Voltage	V _{IN}	-0.3 to +18	V
Output Current	ISINK	30	mA
Operating Temperature	T _{opr}	-40 to +85	°C
Storage Temperature	T _{stg}	−55 to +150	°C

Note: P_D : TA7522S / TA7522F

Electrical Characteristics (Ta = - 40 to +85°C)

Characteristics	Symbol		Test CirCuit	Test Condition	Min	(Note) typ.	Max	Unit
Voltage Gain	Gv		1	V_{CC} = 6V, R _L = 1k Ω f = 10Hz, test circuit 1	60	95	_	dB
Input Offset Voltage	V _{IO}		2	$V_{CC} = 6V, R_L = 1k\Omega$ CMV _{IN} = 3V, test circuit 2		2	10	mV
Input Bias Current	Ц		3	V _{CC} = 6V, CMV _{IN} = 3V test circuit 3	-	-0.2	-2	μA
Input Offset Current	I _{IO}		3	Same as above	-	0.02	0.3	μA
Common-mode Input Voltage	CMVIL		4	$V_{CC} = 6.5V, R_L = 1k\Omega$ $V_{IO} = 20mV,$ test circuit 4	_	-0.5	0	V
	CMVIH			Same as above	5.0	5.3	_	V
		OUT1 OUT2	5	V_{CC} = 5.5V, V_{IN} = 0.1V I_{OL} = 10mA, test circuit 5	_	0.18	0.4	V
Zero Output Voltage	V _{OL}	OUT1		$\begin{array}{l} V_{CC} = 5.5V, V_{IN} = 0.1V, \\ I_{OL} = 15mA, \\ V_{OL} \mbox{ (out1)} \geq 2V, \\ \mbox{test circuit 5} \end{array}$	_	0.25	0.4	V
Output Leakage Current	ILEAK	OUT1 OUT1 OUT2	6	V _{CC} = 6V, V _{OUT} = 30V test circuit 6	_	_	10	μA
		OUT1	6	V_{CC} = 6V, V_{OUT} = 0.4V test circuit 6	_	-1.5	-10	μA
Current Consumption	ICC		7	$V_{CC} = 6.5V, R_L = \infty$ test circuit 7	_	3	7	mA

Note : An ambient temperature of 25°C is assumed for the typical values.

<u>TOSHIBA</u>

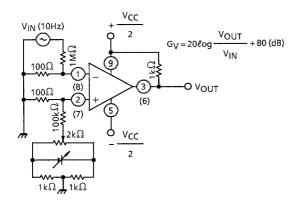
Test Circuit

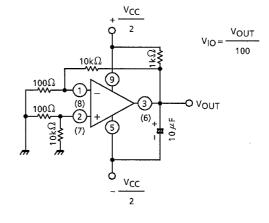
(Shown below is an example for the TA7522S. For the TA7522F, note that the pin numbers are different.)

1. G_V

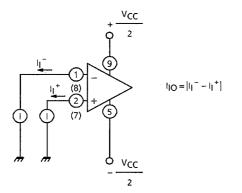
3. I_I,I_{IO}

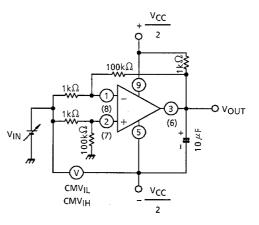
2. V_{IO}





4. CMVIL, CMVIH

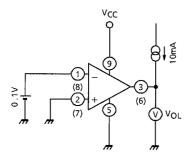




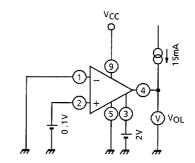
- $\label{eq:CMV_IL} CMV_{IL}: \mbox{ Input voltage relative to pin 5 as it is obtained} \\ \mbox{ when } V_{IN} \mbox{ is decreased until output } V_{OUT} \\ \mbox{ becomes } \pm 2V.$
- $\label{eq:CMV_IH} CMV_{IH}: \mbox{ Input voltage relative to pin 5 as it is obtained} \\ \mbox{ when } V_{IN} \mbox{ is increased until output } V_{OUT} \\ \mbox{ becomes } \pm 2V. \end{cases}$

5. V_{OL}

5.1 OUT1,OUT2



5.2 OUT1

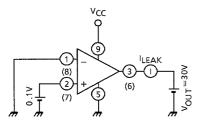


TOSHIBA

6. I_{LEAK}

6.3 OUT1

6.1 OUT1,OUT2



Vcc Q

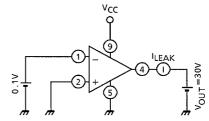
୭

1

2

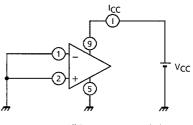
≥. , V{OUT}=0.4V

OUT1



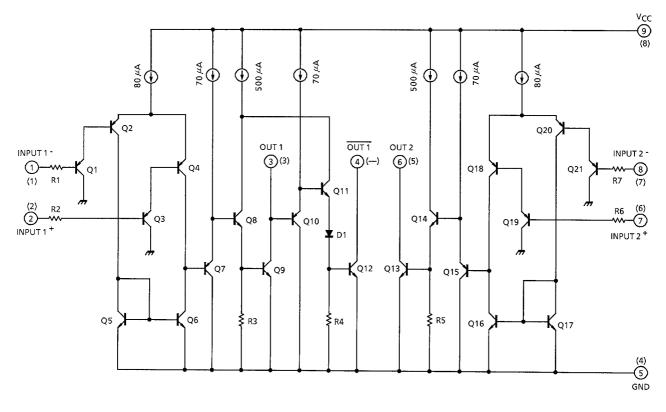
7. Icc OUT1

6.2



All inputs are grounded.

Equivalent Circuit (The pin numbers are explained in order of the TA7522S and the TA7522F.)

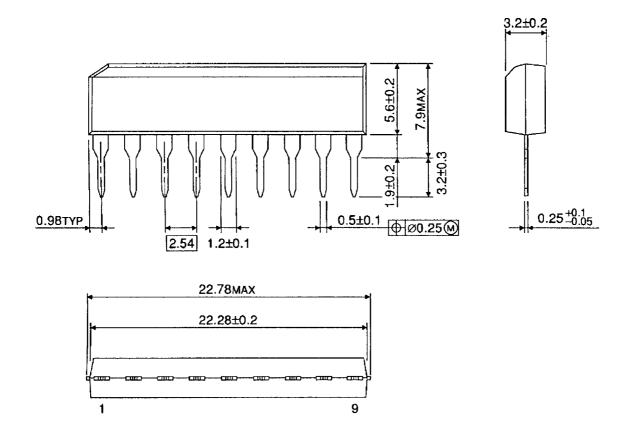


TOSHIBA

Package Dimensions

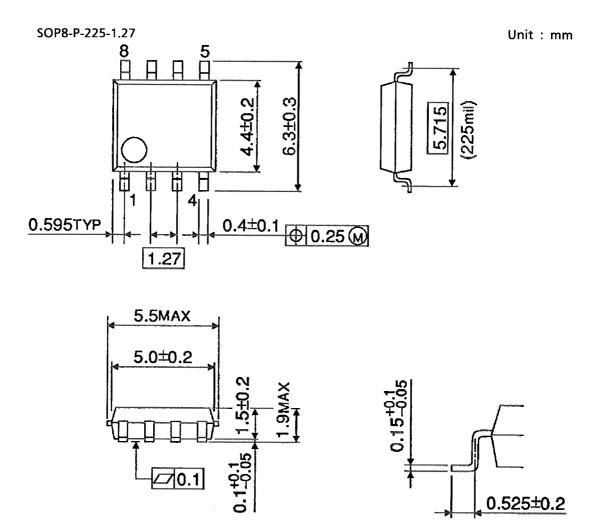
SIP9-P-2.54A

Unit : mm



Weight: 0.92 g (typ.)

Package Dimensions



Weight: 0.08 g (typ.)

RESTRICTIONS ON PRODUCT USE

000707EAA_S

TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability

Handbook" etc..

- The information contained herein is presented only as a guide for the applications of our products. No
 responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other
 rights of the third parties which may result from its use. No license is granted by implication or otherwise under
 any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.